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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: 2878

Examiner: Que Tan Le

In re PATENT APPLICATION of

Applicant(s) : Masashi SANO)

Appl. No. : 10/608,017)

Filed : June 30, 2003)

For : REFLECTIVE SENSOR FILTER FOR)
REFLECTIVE SENSOR, AND)
METHOD OF DETECTING OBJECT)
USING THE SAME)

Atty. Dkt. : AI 287)

**INFORMATION
DISCLOSURE
STATEMENT**

July 15, 2005

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

This is an Information Disclosure Statement submitted in compliance with the timing requirements of 37 C.F.R. §1.97(c)(2), i.e., after a first Office Action on the merits but before Final Rejection and/or Notice of Allowance.

Attached are copies of two Japanese Unexamined Patent Publications No. 2003-207578 and 11-49405 with English-language abstracts and computer translations, and a Japanese Unexamined Patent Publication No. 4-91691 corresponding to U. S. Patent No. 5,172,003. The publications were cited in a Japanese Office Action dated May 31, 2005 for the corresponding Japanese Patent Application No. 2002-197453. Any relevance of the Japanese publications can be gleaned from the English translations. The publications are listed on the attached Form PTO-1449. Consideration of the documents is respectfully requested.

It is hereby certified that each item of information contained in this

FEE ENCLOSED: \$
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Information Disclosure Statement was first cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this Information Disclosure Statement.

Respectfully submitted,

July 15, 2005
Date



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INFORMATION DISCLOSURE
STATEMENT



FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT		Atty Docket AI 287			Application No. 10/608,017		
		Applicant Masashi SANO					
		Filing Date June 30, 2003			Group Unit 2878		
U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date
	AA	5,172,003	12/15/92	NASU et al.			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Sub-Class	Translation
	AL	2003-207578	07/25/03	JAPAN			YES
	AM	11-049405	02/23/99	JAPAN			YES
	AN	4-191691	07/09/92	JAPAN			
	AO						
OTHER (Including Author, Title, Date, Pertinent Pages, etc.)							
	AP						
	AQ						
	AR						
Examiner					Date Considered		
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							